Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/567,006	LI ET AL.
Examiner	Art Unit
Tu M. Nauven	3748

	SEARCHED					
Class	Subclass	Date	Examiner			
60	286	5/2007	TMN			
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. INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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